

**Search Notes**

Application/Control No.

10/783,172

Examiner

Evan Dzierzynski

Applicant(s)/Patent under  
Reexamination

MAYER ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	547	7/21/2005	ED
	548	7/21/2005	ED
	549	7/21/2005	ED

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST word search in the claims, in PG PUBS		6/1/2006	ED

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search strategy from Peggy Niels	7/21/2005	ED
EAST word search	7/21/2005	ED
EAST updated word search	11/30/2005	ED